

Search Notes**Application/Control No.**

10636044

Applicant(s)/Patent Under Reexamination

CHIU ET AL.

Examiner

Augustine, Nicholas

Art Unit

2179

SEARCHED

Class	Subclass	Date	Examiner
709	201-205, 214, 231-232	6/5/08	NA
715	748, 751, 753, 761, 863	6/5/08	NA
709	201-205, 214, 231-232	8/21/08	NA
710	1	8/21/08	NA
715	748, 751, 753, 761, 863	8/21/08	NA
709	201-205, 214, 231-232	3/12/2009	NA
710	1	3/12/2009	NA
715	748, 751, 753, 761, 863	3/12/2009	NA
709	201-205, 214, 231-232	8/19/2009	NA
715	748, 751, 753, 761, 863	8/19/2009	NA
715	730,737,748,751,753,761,766,863	2/4/2010	NA
709	201-205, 214, 231-232	2/4/2010	NA
715	730,737,748,751,753,761,766,863	7/17/2010	NA
709	201-205, 214, 231-232	7/17/2010	NA
715	730,737,748,751,753,761,766,863	4/11/2011	NA
709	201-205, 214, 231-232	7/30/2011	NA
715	730,737,748,751,753,761,766,863	7/30/2011	NA

SEARCH NOTES

Search Notes	Date	Examiner
Updated Search	06/26/2007	NA
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	8/21/08	NA
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	3/12/2009	NA
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	8/19/2009	NA
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	2/4/2010	NA
Consulted with Ba Huynh	2/4/2010	NA
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	7/17/2010	NA
Consulted with Ba Huynh	7/17/2010	NA
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	4/11/2011	NA

SEARCH NOTES

Search Notes	Date	Examiner
Updated East Search: US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	7/30/2011	NA

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
715	730,737,748,751,753,761,766,863	2/4/2010	NA
709	201-205, 214, 231-232	2/4/2010	NA
715	730,737,748,751,753,761,766,863	7/17/2010	NA
709	201-205, 214, 231-232	7/17/2010	NA
709	201-205, 214, 231-232	7/30/2011	NA
715	730,737,748,751,753,761,766,863	7/30/2011	NA

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